

<b>Notice of References Cited</b>	Application/Control No. <b>09/507,825</b>	Applicant(s)/Patent Under Reexam <b>Yamazaki et al.</b>	
	Examiner <b>David L. Lewis</b>	Art Unit <b>2673</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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C	6,239,781 B1	5/2001	Fujisawa	345	147
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**NON-PATENT DOCUMENTS**

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